FAIRCHILD SEMICONDUCTOR®

July 2009

UniFET™

# FDP17N60N / FDPF17N60NT

## N-Channel MOSFET

### 600V, 17A, 0.34Ω



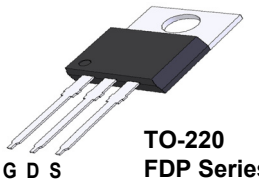
## Features

- $R_{DS(on)}$ = 0.29Ω ( Typ.)@ $V_{GS}$ = 10V, $I_D$ = 8.5A
- Low Gate Charge ( Typ. 48nC)
- Low $C_{rss}$ ( Typ. 23pF)
- Fast Switching
- 100% Avalanche Tested
- Improved dv/dt Capability
- RoHS Compliant

## Description

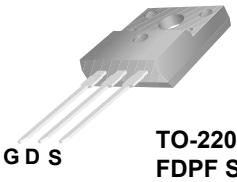
These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.



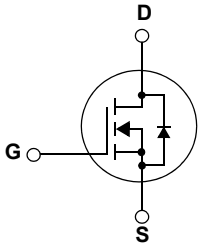
G D S

**TO-220**
**FDP Series**



G D S

**TO-220F**
**FDPF Series**




## MOSFET Maximum Ratings $T_C$ = 25°C unless otherwise noted*

| Symbol | Parameter | | | FDP17N60N | FDPF17N60NT | Units |
|---|---|---|---|---|---|---|
| $V_{DSS}$ | Drain to Source Voltage | | | 600 | | V |
| $V_{GSS}$ | Gate to Source Voltage | | | ±30 | | V |
| $I_D$ | Drain Current | -Continuous ($T_C$ = 25°C) | | 17 | 17* | A |
| | | -Continuous ($T_C$ = 100°C) | | 10.2 | 10.2* | |
| $I_{DM}$ | Drain Current | - Pulsed | (Note 1) | 68 | 68* | A |
| $E_{AS}$ | Single Pulsed Avalanche Energy | | (Note 2) | 838 | | mJ |
| $I_{AR}$ | Avalanche Current | | (Note 1) | 17 | | A |
| $E_{AR}$ | Repetitive Avalanche Energy | | (Note 1) | 24.5 | | mJ |
| dv/dt | Peak Diode Recovery dv/dt | | (Note 3) | 10 | | V/ns |
| $P_D$ | Power Dissipation | ($T_C$ = 25°C) | | 245 | 62.5 | W |
| | | - Derate above 25°C | | 2.0 | 0.5 | W/°C |
| $T_J$, $T_{STG}$ | Operating and Storage Temperature Range | | | -55 to +150 | | °C |
| $T_L$ | Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds | | | 300 | | °C |

*Drain current limited by maximum junction temperature

## Thermal Characteristics

| Symbol | Parameter | FDP17N60N | FDPF17N60NT | Units |
|---|---|---|---|---|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 0.51 | 2.0 | °C/W |
| $R_{\theta CS}$ | Thermal Resistance, Case to Heat Sink Typ. | - | - | |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | 62.5 | 62.5 | |

## Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|---|---|---|---|---|---|
| FDP17N60N | FDP17N60N | TO-220 | - | - | 50 |
| FDPF17N60NT | FDPF17N60NT | TO-220F | - | - | 50 |

## Electrical Characteristics $T_C$ = 25°C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|---|---|---|---|---|---|---|
| **Off Characteristics** | | | | | | |
| $BV_{DSS}$ | Drain to Source Breakdown Voltage | $I_D$ = 250μA, $V_{GS}$ = 0V, $T_C$ = 25°C | 600 | - | - | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D$ = 250μA, Referenced to 25°C | - | 0.8 | - | V/°C |
| $I_{DSS}$ | Zero Gate Voltage Drain Current | $V_{DS}$ = 600V, $V_{GS}$ = 0V | - | - | 1 | μA |
| | | $V_{DS}$ = 480V, $V_{GS}$ = 0V, $T_C$ = 150°C | - | - | 10 | |
| $I_{GSS}$ | Gate to Body Leakage Current | $V_{GS}$ = ±30V, $V_{DS}$ = 0V | - | - | ±100 | nA |
| **On Characteristics** | | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS}$ = $V_{DS}$, $I_D$ = 250μA | 3.0 | - | 5.0 | V |
| $R_{DS(on)}$ | Static Drain to Source On Resistance | $V_{GS}$ = 10V, $I_D$ = 8.5A | - | 0.29 | 0.34 | Ω |
| $g_{FS}$ | Forward Transconductance | $V_{DS}$ = 20V, $I_D$ = 8.5A (Note 4) | - | 21 | - | S |
| **Dynamic Characteristics** | | | | | | |
| $C_{iss}$ | Input Capacitance | $V_{DS}$ = 25V, $V_{GS}$ = 0V, f = 1MHz | - | 2285 | 3040 | pF |
| $C_{oss}$ | Output Capacitance | | - | 310 | 410 | pF |
| $C_{rss}$ | Reverse Transfer Capacitance | | - | 23 | 35 | pF |
| $Q_{g(tot)}$ | Total Gate Charge at 10V | $V_{DS}$ = 480V $I_D$ = 17A, $V_{GS}$ = 10V (Note 4, 5) | - | 48 | 65 | nC |
| $Q_{gs}$ | Gate to Source Gate Charge | | - | 13 | - | nC |
| $Q_{gd}$ | Gate to Drain “Miller” Charge | | - | 20 | - | nC |
| **Switching Characteristics** | | | | | | |
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DD}$ = 300V, $I_D$ = 17A, $V_{GS}$ = 10V, $R_{GEN}$ = 25Ω (Note 4, 5) | - | 48 | 106 | ns |
| $t_r$ | Turn-On Rise Time | | - | 79 | 168 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | - | 128 | 266 | ns |
| $t_f$ | Turn-Off Fall Time | | - | 62 | 134 | ns |
| **Drain-Source Diode Characteristics** | | | | | | |
| $I_S$ | Maximum Continuous Drain to Source Diode Forward Current | | - | - | 74 | A |
| $I_{SM}$ | Maximum Pulsed Drain to Source Diode Forward Current | | - | - | 68 | A |
| $V_{SD}$ | Drain to Source Diode Forward Voltage | $V_{GS}$ = 0V, $I_{SD}$ = 17A | - | - | 1.4 | V |
| $t_{rr}$ | Reverse Recovery Time | $V_{GS}$ = 0V, $I_{SD}$ = 17A, $dI_F/dt$ = 100A/μs (Note 4) | - | 575 | - | ns |
| $Q_{rr}$ | Reverse Recovery Charge | | - | 7.2 | - | μC |

**Notes:**

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. L = 5.8mH, $I_{AS}$ = 17A, $V_{DD}$ = 50V, $R_G$ = 25Ω, Starting $T_J$ = 25°C
3. $I_{SD}$ ≤ 17A, di/dt ≤ 200A/μs, $V_{DD}$ ≤ $BV_{DSS}$, Starting $T_J$ = 25°C
4. Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 2%
5. Essentially Independent of Operating Temperature Typical Characteristics

## Typical Performance Characteristics

**Figure 1. On-Region Characteristics**

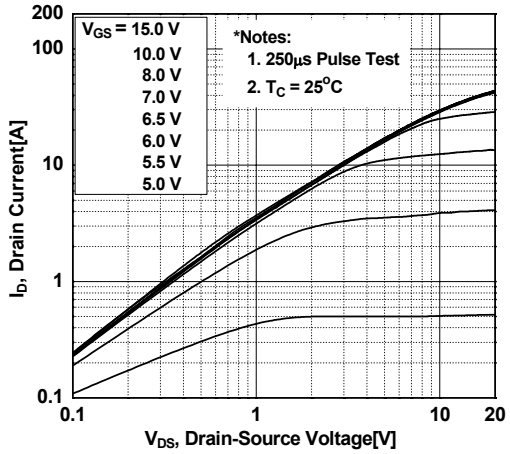



**Figure 2. Transfer Characteristics**

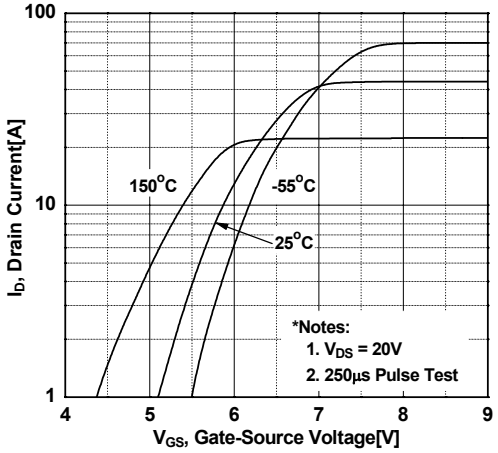



**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**

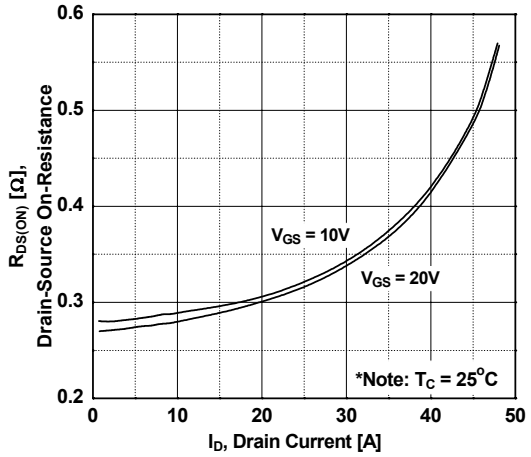



**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**

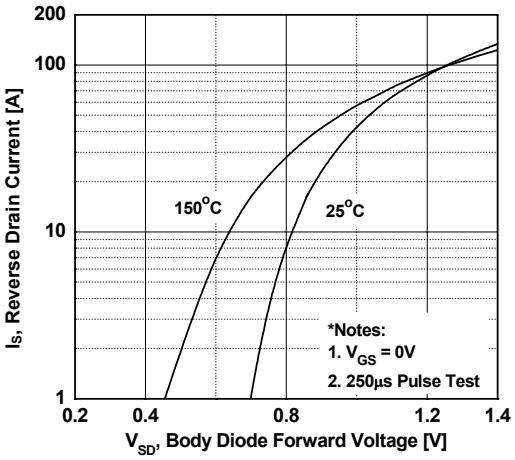



**Figure 5. Capacitance Characteristics**

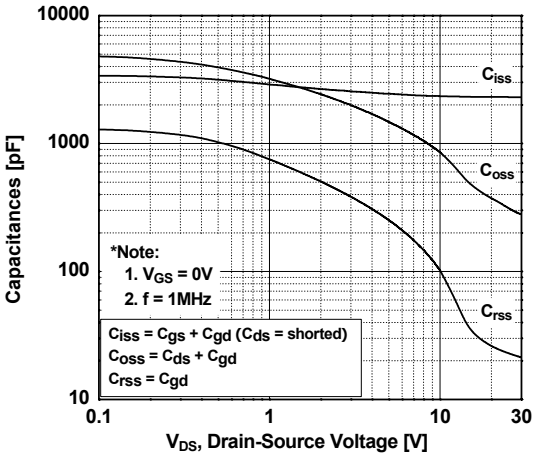
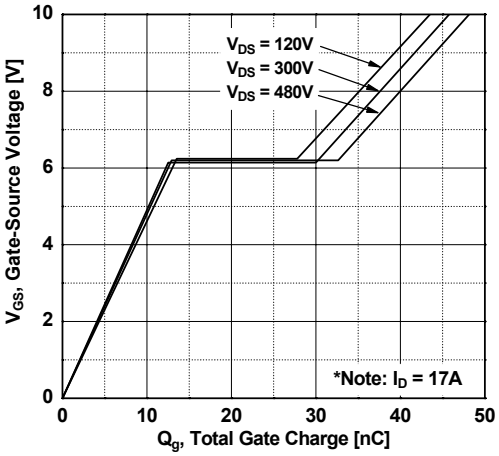



**Figure 6. Gate Charge Characteristics**



## Typical Performance Characteristics (Continued)

**Figure 7. Breakdown Voltage Variation vs. Temperature**

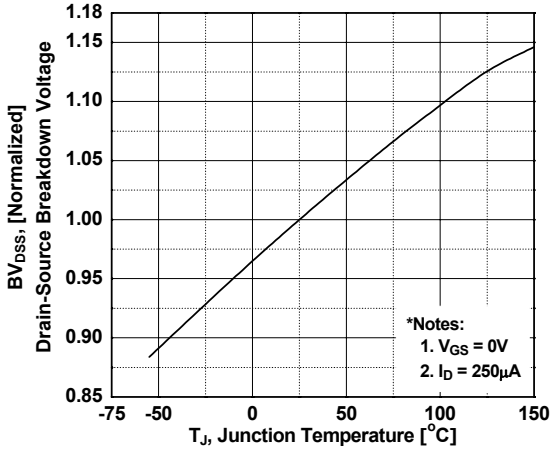



**Figure 8. On-Resistance Variation vs. Temperature**

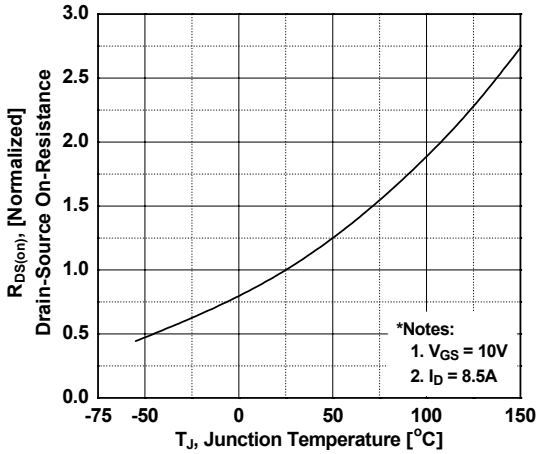



**Figure 9. Maximum Safe Operating Area -FDPF17N60NT**

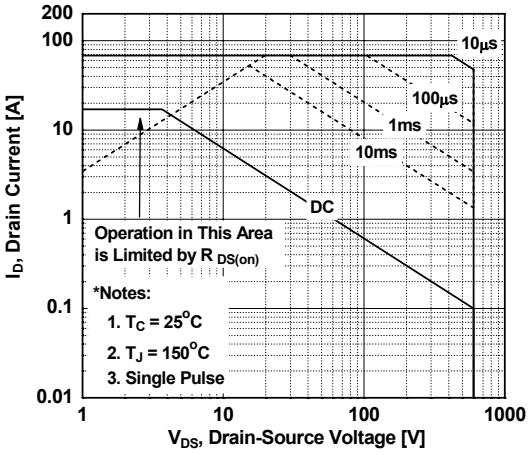



**Figure 10. Maximum Drain Current vs. Case Temperature**

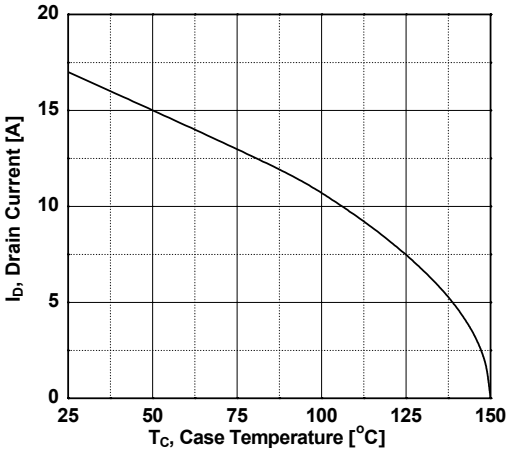
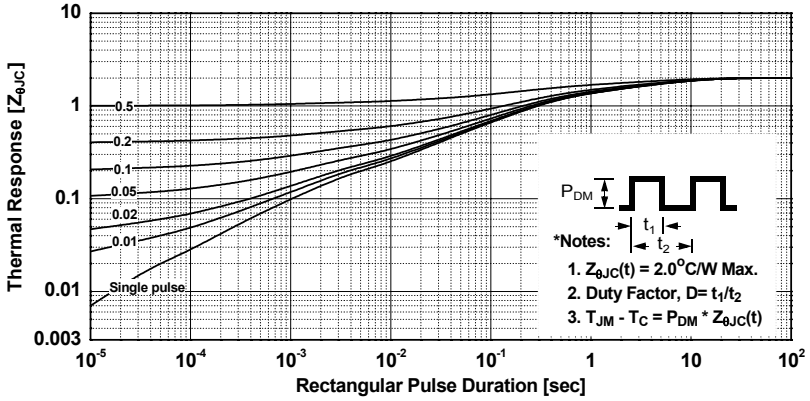
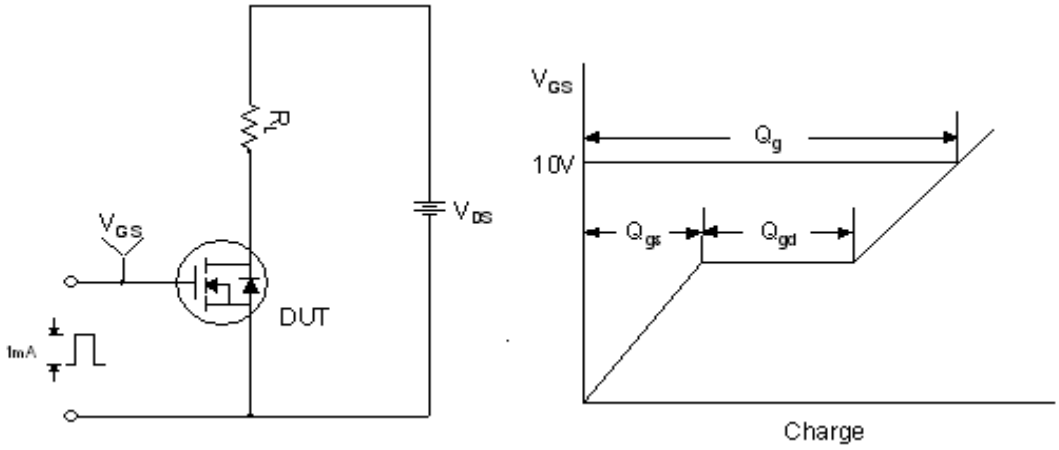


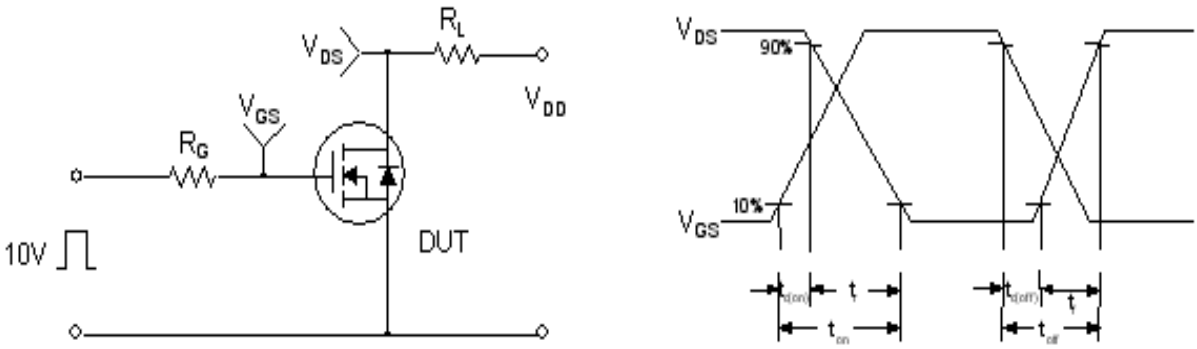

**Figure 11. Transient Thermal Response Curve -FDPF17N60NT**



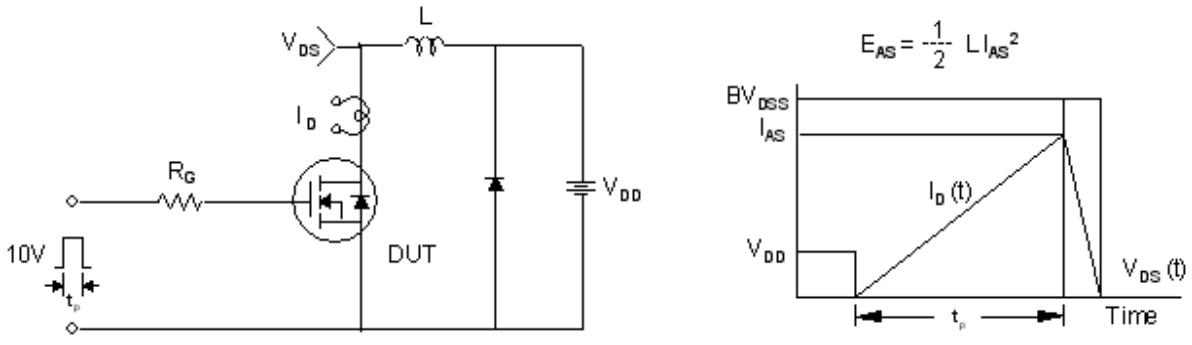
**Gate Charge Test Circuit & Waveform**



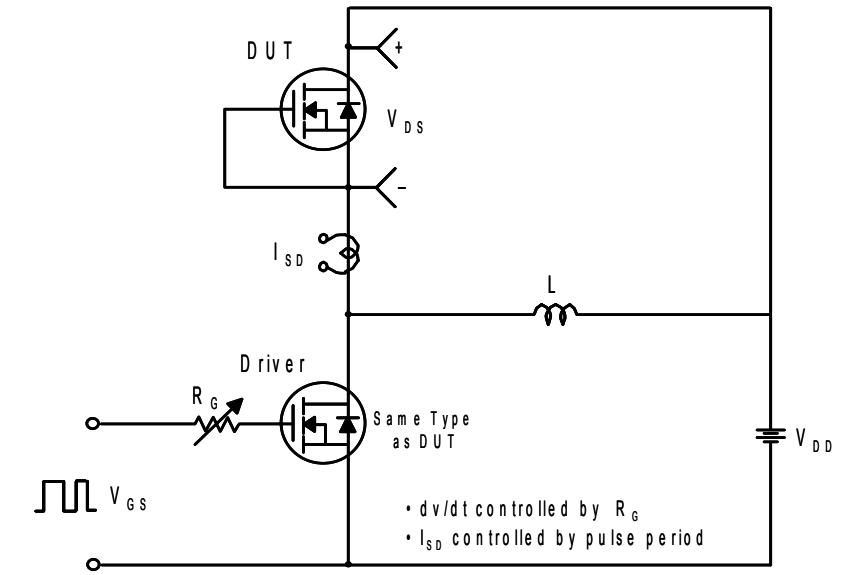

**Resistive Switching Test Circuit & Waveforms**

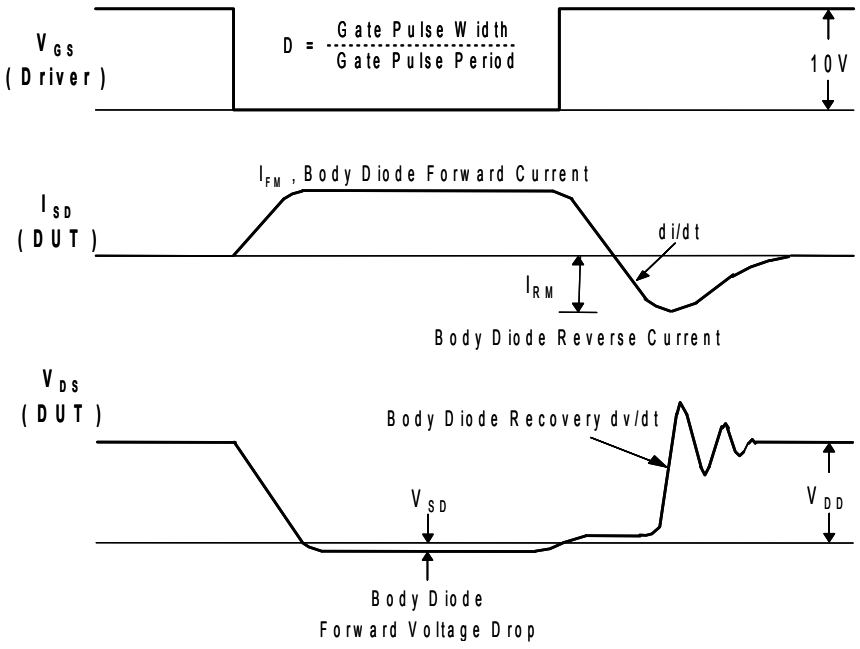



**Unclamped Inductive Switching Test Circuit & Waveforms**



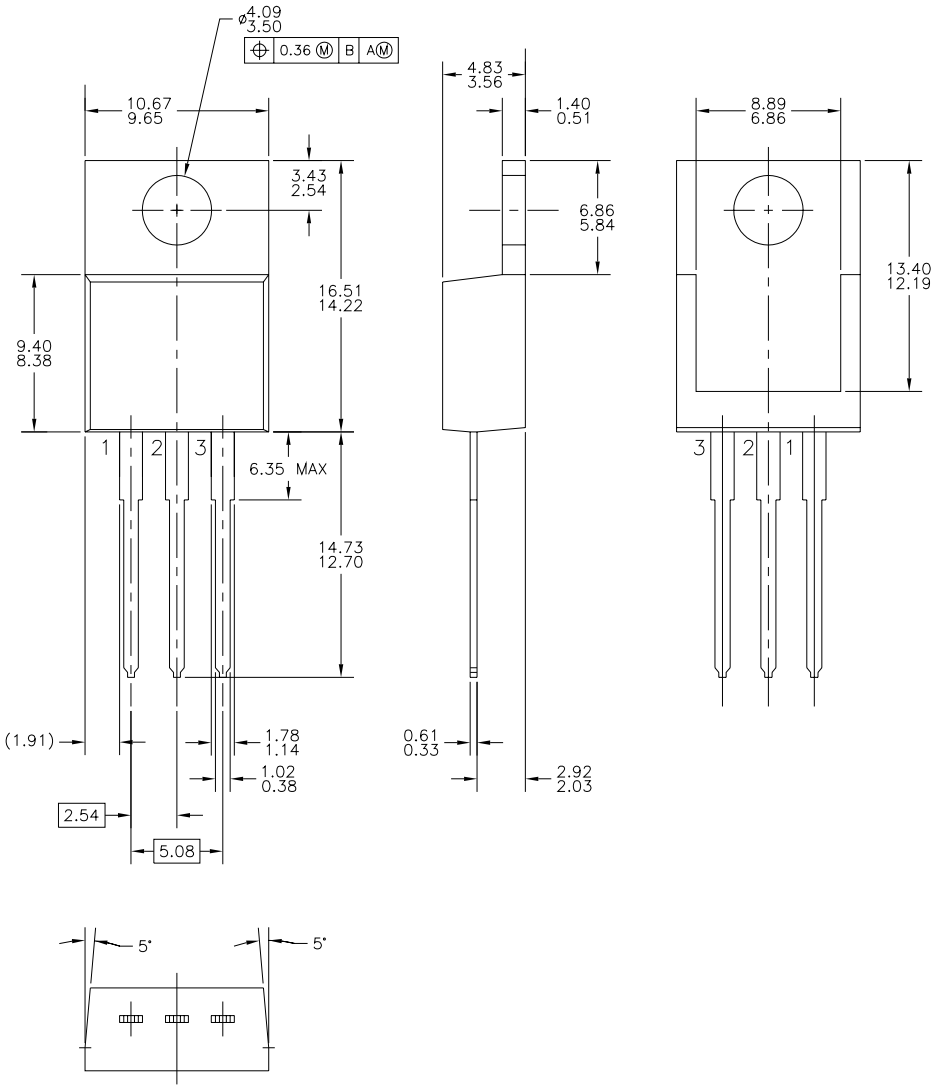
**Peak Diode Recovery dv/dt Test Circuit & Waveforms**



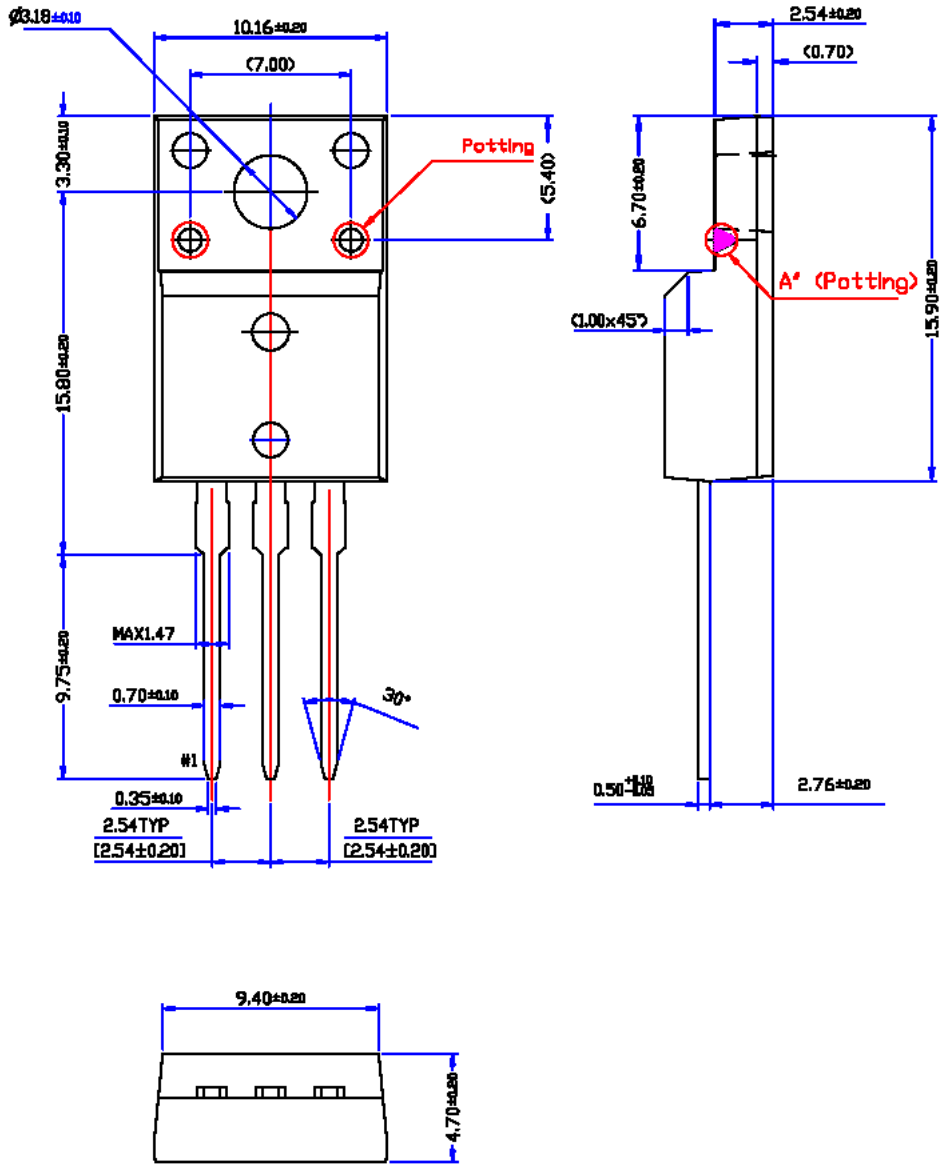
## Mechanical Dimensions

TO-220



## Package Dimensions

# TO-220F Potted




* Front/Back Side Isolation Voltage : 4000V

Dimensions in Millimeters

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